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Celative Error

Soft Error Rate Predictor for Combination Circuits

Product Overview

MASkIt is a tool that quickly and accurately predicts the Soft Error Rate in combinational circuits. It uses as inputs a netlist of the circuit and the signal probability distribution of its primary inputs to compute the circuit's vulnerability: the probability that a particle strike at any node of the circuit results in a bit flip in one or more primary outputs.

Supported Architectures

Any combinational circuits described in the format produced by popular synthesis tools, such as RTL **Compiler** and **Yosys**

Extensions & Tools

- Precise reliability estimation avoiding RTL fault-injection campaigns.
 - Speedup from 170x to 800x Estimation accounts
- Technology node, Supply voltage and Temperature

Supported Fault Models

Transient

1easurements

Vulnerability factor for each node of the circuit



development has been made with a

"MASklt

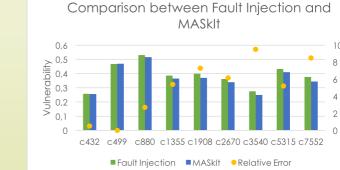
great tool flow in

mind "

- ARCO Research Group (UPC)

Analysis Enhancements

MASkIt can be connected to any architecture-level simulator tool, providing models of micro architectural components otherwise totally missing



c880 c432 C499 c1908 c1355 c2670 C3540c5315 c7552

Speedup

900 800

700

200

100

0

Contact Us

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Gate models are automatically extracted from the

All gates in the model

Target Components

technology library

Cross-Laver Early Reliability Evaluation for the Computing cOntinuun

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